

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 01217328 A	08-1989	Japan	MATSUMOTO et al.	G02F 01/35
	O					
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**NON-PATENT DOCUMENTS**

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